



Shri Mata Vaishno Devi University

**Consolidated Result of Lateral entry Students (B. Tech CSE, ME, ECE), Pending result of M.SC. batch 2017
(Physics, Mathematics, Biotechnology) and Revised result of July- Nov., 2017**

Dated: 06/03/2018

S. No.	Entry_no.	Student_name	Se m	CGP A	SGPA	Credits_Earned	Backlog_List
1.	15BCS054	Arjun Gupta	5	6.70	7.00	111	Nil
2.	15BCS053	Shelly Chopra	5	6.64	6.75	111	NIL
3.	16BCS062	MARVI KHAJURIA	3	6.63	5.05	62	* ECL 2072 Digital Electronics Fundamentals(3) * PCN 1010 NSS(0)
4.	16BCS063	ASHWANI LAHORIA	3	7.33	4.05	56	* CSL 2031 Data Structures(3) * ECL 2072 Digital Electronics Fundamentals(3) * PCL 2042 Introduction to Logic(3)
5.	17MMB001	SUVIDHA ZUTSHI	1	7.16	7.16	19	NIL
6.	16BEC010	AKARSH RAKWAL	3	5.93	5.17	56	* ECL 1022 Network Analysis & Synthesis(4) * ECL 1030 Electronic Circuits & Simulation(4) * ECL 2040 Electromagnetic Field Theory(4) * ECP 1030 Circuits & Simulation Lab(1) * PCN 1010 NSS(0)
7.	16BEC029	KOMAL RAJPUT	3	6.15	5.08	65	* ECL 2040 Electromagnetic Field Theory(4)
8.	16BEC050	RYTHAM PURI	3	6.29	5.65	69	Nil
9.	16BEC059	SHUBAM SARYAL	3	6.74	6.3	69	Nil
10.	16BEC072	BHUPESH SHARMA	3	7.83	8.52	69	Nil
11.	14BEC010	AKSHITA SHARMA	7	7.1	8.29	158	Nil
12.	14BEC037	NISHU RANA	7	7.45	8.47	158	Nil
13.	15BEC002	AAGMAN JOSHI	5	7.54	8.35	114	Nil
14.	15BEC003	AAKANKSHA SABHARWAL	5	5.54	6.68	114	* PCN 1010 NSS(0)
15.	15BEC007	ASHNA ARYANI	5	8.41	8.7	114	Nil
16.	15BEC013	MAHIMA GUPTA	5	5.82	5.11	110	* ECL 2020 Industrial Electronics(4) * PCN 1010 NSS(0)
17.	15BEC016	RAMESHWAR	5	7.68	8.26	114	Nil

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		PRATAP SINGH					
18.	15BEC019	SAKET PURI	5	5.51	4.03	78	* ECL 1030 Electronic Circuits & Simulation(4) * ECL 2020 Industrial Electronics(4) * ECL 2030 Linear Integrated Circuits & Applications(4) * ECL 2040 Electromagnetic Field Theory(4) * ECL 2060 Microprocessor Systems(4) * ECL 2070 Digital Electronics
19.	17MMM036	SAKSHI VERMA	1	7.24	7.24	21	NIL
20.	17MMM037	RAHUL SHARMA	1	7.43	7.43	21	NIL
21.	17MMM038	RASHMI DEVI	1	7.67	7.67	21	NIL
22.	17MMM039	ROOPALI SANGRAL	1	7.62	7.62	21	NIL
23.	17MMM040	BHARTI MANHAS	1	7.67	7.67	21	NIL
24.	17MMM041	PUNIT PUNIA	1	7.24	7.24	21	NIL
25.	17MMM042	SAZIA	1	6.67	6.67	21	NIL
26.	17MMM043	TARANJEET SINGH	1	7.81	7.81	21	NIL
27.	17MBT025	AKASH SHARMA	1	9.13	9.13	20	NIL
28.	17MBT026	SADIA PARVEZ	1	6.28	6.28	20	NIL
29.	17MBT027	AMIT CHOUDHARY	1	8.58	8.58	20	NIL
30.	17MBT028	LOVE GUPTA	1	7.43	7.43	20	NIL
31.	17MBT029	NISHANT	1	6.98	6.98	20	NIL
32.	17MBT030	VAISHALI SHARMA	1	6.48	6.48	20	NIL
33.	17MMA018	AAFAQ AMIN TAK	1	7.00	7.00	20	NIL

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JA (Exam)

AR (Exam)

Faculty Incharge(Exam)



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34.	17MMS018	JASIYA FAYAZ	1	7.4	7.4	20	NIL
35.	17MMS017	MEHVISH YASIN	1	7.4	7.4	20	NIL
36.	17BME034	PAARTH GUPTA	1	6.22	6.22	23	NIL
37.	17MPY001	ABHISHEK JASRITIA	1	7.09	7.09	22	NIL
38.	16BME044	SHUBHAM KHAJURIA	3	6.51	5.05	72	PCN 1010 NSS(0)
39.	16BME045	SOUHARD NARANG	3	6.65	4.87	66	MTL 2023, PCL 2042, PCN 1010 NSS(0)
40.	16BME046	NARAYAN VISHAL	3	6.88	5.16	69	PCL 2042(3), PCN 1010 NSS(0)
41.	16BME047	ABHINAV VERMA	3	6.27	5.04	69	PCL 2042(3), PCN 1010 NSS(0)
42.	16BEC078	ANAM	3	7.21	5.04	62	ECL 2040(4), PCL 2042(3) PCN 1010 NSS(0)
43.	16BEC077	ADITY PANDOH	3	6.66	5.04	65	ECL 2040, PCN 1010 NSS(0)
44.	16BEC076	SHIVANSH RAINA	3	6.98	4.12	62	ECL 2040(4), PCL 2042(3) PCN 1010 NSS(0)

“All efforts have been made to publish this result after checking the entries properly as per award sheet received. However, the result can stand revised in case some discrepancy is observed. Please contact Examination Wing for details of backlog.”

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Faculty Incharge(Exam)